



# THE DATASHEET OF VND600TR-E





## DOUBLE CHANNEL HIGH SIDE DRIVER

**Table 1. General Features**

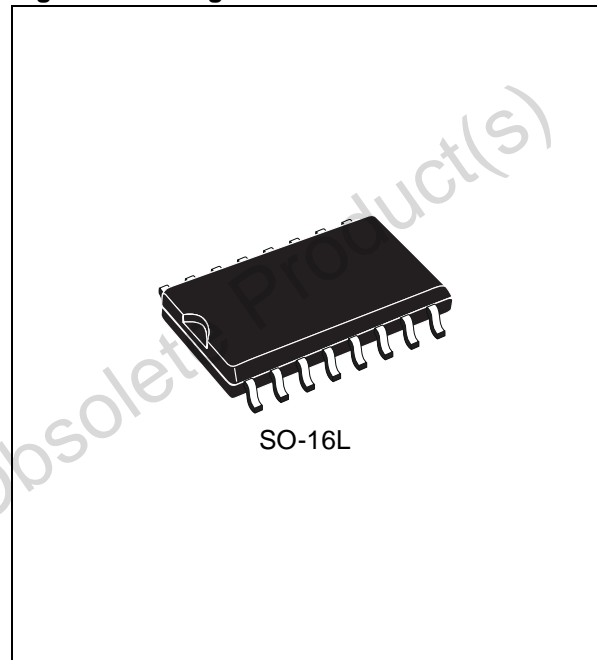
| Type     | R <sub>DS(on)</sub> | I <sub>lim</sub> | V <sub>CC</sub> |
|----------|---------------------|------------------|-----------------|
| VND600-E | 35 mΩ               | 25 A             | 36 V            |

- DC SHORT CIRCUIT CURRENT: 25 A
- CMOS COMPATIBLE INPUTS
- PROPORTIONAL LOAD CURRENT SENSE
- UNDERVOLTAGE AND OVERVOLTAGE SHUT-DOWN
- OVERVOLTAGE CLAMP
- THERMAL SHUT DOWN
- CURRENT LIMITATION
- VERY LOW STAND-BY POWER DISSIPATION
- PROTECTION AGAINST:
  - LOSS OF GROUND AND LOSS OF V<sub>CC</sub>
- REVERSE BATTERY PROTECTION (\*)
- IN COMPLIANCE WITH THE 2002/95/EC EUROPEAN DIRECTIVE

### DESCRIPTION

The VND600-E is a monolithic device made using STMicroelectronics VIPower M0-3 technology. It is intended for driving resistive or inductive loads with one side connected to ground. Active V<sub>CC</sub> pin voltage clamp protects the device against low energy spikes (see ISO7637 transient compatibility table).

**Figure 1. Package**



This device has two channels in high side configuration; each channel has an analog sense output on which the sensing current is proportional (according to a known ratio) to the corresponding load current. Built-in thermal shut-down and outputs current limitation protect the chip from over temperature and short circuit. Device turns off in case of ground pin disconnection.

**Table 2. Order Codes**

| Package | Tube     | Tape and Reel |
|---------|----------|---------------|
| SO-16L  | VND600-E | VND600TR-E    |

Note: (\*) See application schematic at page 9

Figure 2. Block Diagram

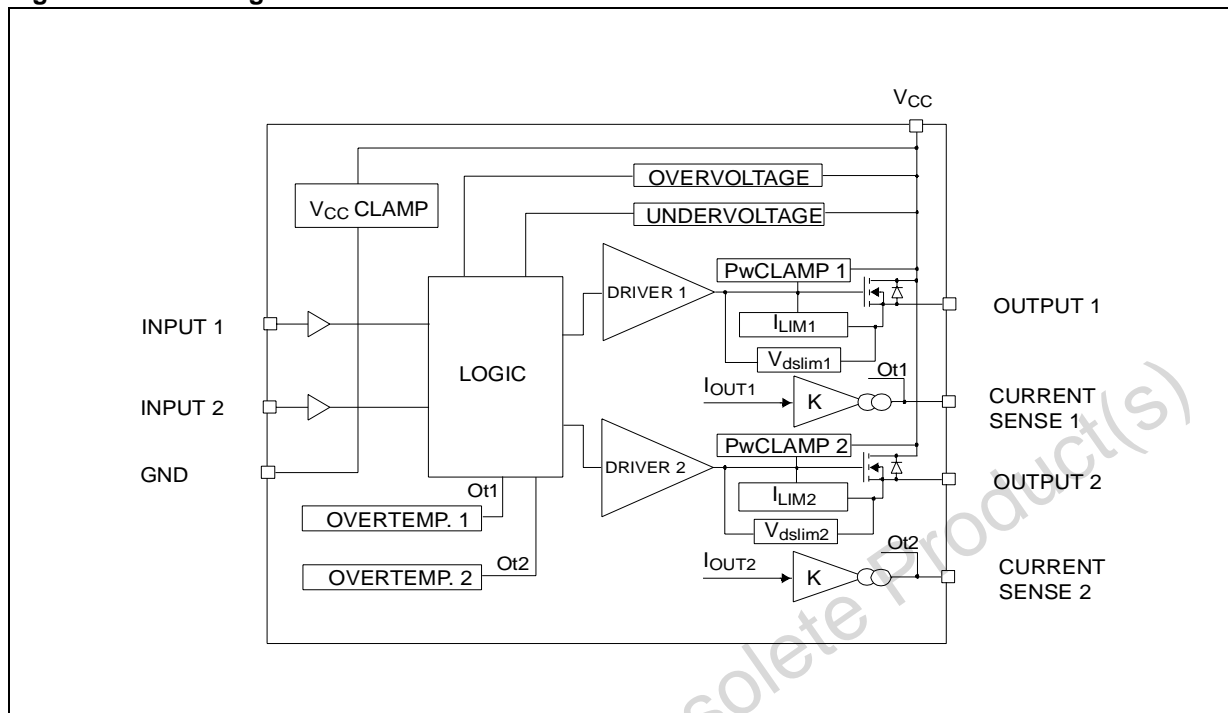


Table 3. Absolute Maximum Ratings

| Symbol            | Parameter   | Value              | Unit |
|-------------------|---|--------------------|------|
| V <sub>CC</sub>   | DC supply voltage   | 41                 | V    |
| -V <sub>CC</sub>  | Reverse supply voltage  | -0.3               | V    |
| -I <sub>GND</sub> | DC reverse ground pin current   | -200               | mA   |
| I <sub>OUT</sub>  | Output current  | Internally limited | A    |
| I <sub>R</sub>    | Reverse output current  | -21                | A    |
| I <sub>IN</sub>   | Input current   | +/- 10             | mA   |
| V <sub>ESD</sub>  | Electrostatic Discharge (Human Body Model:<br>R=1.5KΩ; C=100pF)   |                    |      |
|                   | - INPUT   | 4000               | V    |
|                   | - CURRENT SENSE   | 2000               | V    |
|                   | - OUTPUT  | 5000               | V    |
|                   | - V <sub>CC</sub>   | 5000               | V    |
| E <sub>MAX</sub>  | Maximum Switching Energy<br>(L=0.12mH; R <sub>L</sub> =0Ω; V <sub>bat</sub> =13.5V; T <sub>jstart</sub> =150°C;<br>I <sub>L</sub> =40A) | 136                | mJ   |
| P <sub>tot</sub>  | Power dissipation at T <sub>c</sub> =25°C   | 8.3                | W    |
| T <sub>j</sub>    | Junction operating temperature  | Internally limited | °C   |
| T <sub>c</sub>    | Case operating temperature  | -40 to 150         | °C   |
| T <sub>STG</sub>  | Storage temperature   | -55 to 150         | °C   |

Figure 3. Configuration Diagram (Top View) & Suggested Connections for Unused and N.C. Pins

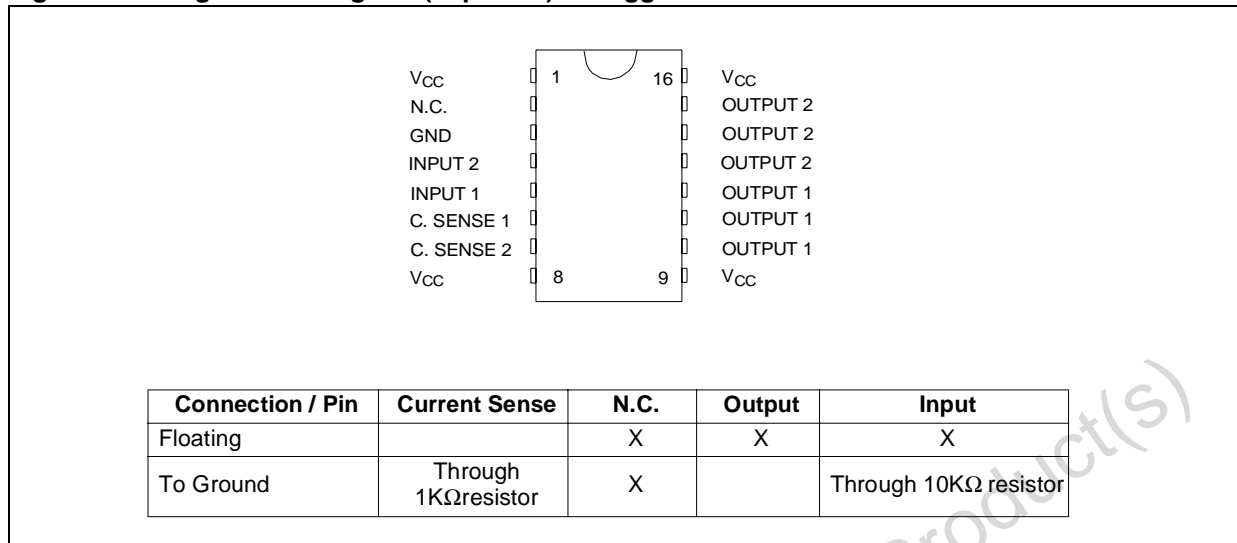


Figure 4. Current and Voltage Conventions

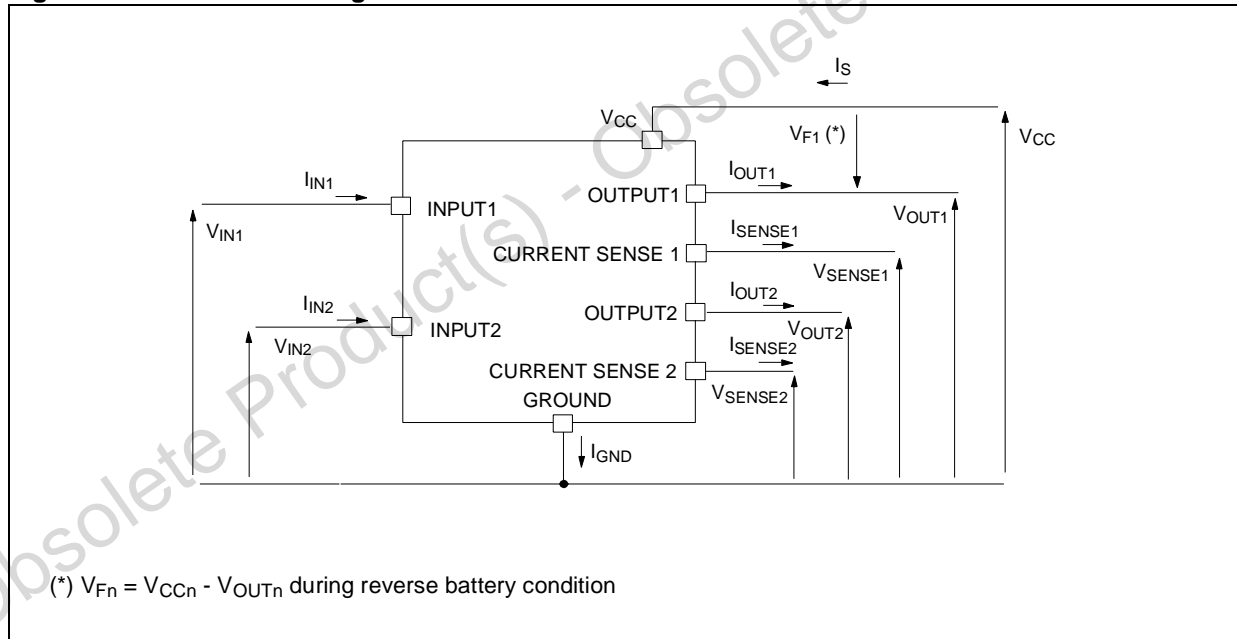


Table 4. Thermal Data

| Symbol                | Parameter                                 | Value            | Unit |
|-----------------------|---|------------------|------|
| R <sub>thj-lead</sub> | Thermal resistance junction-lead (MAX)    | 15               | °C/W |
| R <sub>thj-amb</sub>  | Thermal resistance junction-ambient (MAX) | 65 (*)   48 (**) | °C/W |

Note: (\*) When mounted on a standard single-sided FR-4 board with 0.5cm<sup>2</sup> of Cu (at least 35µm thick). Horizontal mounting and no artificial air flow

Note: (\*\*) When mounted on a standard single-sided FR-4 board with 6cm<sup>2</sup> of Cu (at least 35µm thick). Horizontal mounting and no artificial air flow.

**ELECTRICAL CHARACTERISTICS**

 (8V < V<sub>CC</sub> < 36V; -40°C < T<sub>j</sub> < 150°C; unless otherwise specified)

(Per each channel)

**Table 5. Power**

| Symbol                | Parameter                | Test Conditions  | Min. | Typ.     | Max.            | Unit           |
|-----------------------|--------------------------|--|------|----------|-----------------|----------------|
| V <sub>CC</sub> (**)  | Operating supply voltage |  | 5.5  | 13       | 36              | V              |
| V <sub>USD</sub> (**) | Undervoltage shutdown    |  | 3    | 4        | 5.5             | V              |
| V <sub>OV</sub> (**)  | Overvoltage shutdown     |  | 36   |          |                 | V              |
| R <sub>ON</sub>       | On state resistance      | I <sub>OUT</sub> =5A; T <sub>j</sub> =25°C<br>I <sub>OUT</sub> =5A; T <sub>j</sub> =150°C<br>I <sub>OUT</sub> =3A; V <sub>CC</sub> =6V   |      |          | 35<br>70<br>120 | mΩ<br>mΩ<br>mΩ |
| V <sub>clamp</sub>    | Clamp voltage            | I <sub>CC</sub> =20 mA (see note 1)  | 41   | 48       | 55              | V              |
| I <sub>S</sub> (**)   | Supply current           | Off State; V <sub>CC</sub> =13V; V <sub>IN</sub> =V <sub>OUT</sub> =0V<br>Off State; V <sub>CC</sub> =13V; V <sub>IN</sub> =V <sub>OUT</sub> =0V;<br>T <sub>j</sub> =25°C<br>On state; V <sub>IN</sub> =5V; V <sub>CC</sub> =13V; I <sub>OUT</sub> =0A;<br>R <sub>SENSE</sub> =3.9kΩ |      | 12<br>12 | 40<br>25        | μA<br>μA       |
| I <sub>L(off1)</sub>  | Off state output current | V <sub>IN</sub> =V <sub>OUT</sub> =0V  | 0    |          | 50              | μA             |
| I <sub>L(off2)</sub>  | Off State Output Current | V <sub>IN</sub> =0V; V <sub>OUT</sub> =3.5V  | -75  |          | 0               | μA             |
| I <sub>L(off3)</sub>  | Off State Output Current | V <sub>IN</sub> =V <sub>OUT</sub> =0V; V <sub>CC</sub> =13V; T <sub>j</sub> =125°C   |      |          | 5               | μA             |
| I <sub>L(off4)</sub>  | Off State Output Current | V <sub>IN</sub> =V <sub>OUT</sub> =0V; V <sub>CC</sub> =13V; T <sub>j</sub> =25°C  |      |          | 3               | μA             |

Note: (\*\*) Per device.

 Note: 1. V<sub>clamp</sub> and V<sub>OV</sub> are correlated. Typical difference is 5V.

**Table 6. Protection (Per each channel) (See note 2)**

| Symbol             | Parameter                      | Test Conditions   | Min.                | Typ.                | Max.                | Unit   |
|--------------------|--------------------------------|---|---------------------|---------------------|---------------------|--------|
| I <sub>lim</sub>   | DC short circuit current       | V <sub>CC</sub> =13V<br>5.5V < V <sub>CC</sub> < 36V      | 25                  | 40                  | 70<br>70            | A<br>A |
| T <sub>TSD</sub>   | Thermal shut-down temperature  |   | 150                 | 175                 | 200                 | °C     |
| T <sub>R</sub>     | Thermal reset temperature      |   | 135                 |                     |                     | °C     |
| T <sub>HYST</sub>  | Thermal hysteresis             |   | 7                   | 15                  |                     | °C     |
| V <sub>demag</sub> | Turn-off output voltage clamp  | I <sub>OUT</sub> =2A; V <sub>IN</sub> =0V; L=6mH          | V <sub>CC</sub> -41 | V <sub>CC</sub> -48 | V <sub>CC</sub> -55 | V      |
| V <sub>ON</sub>    | Output voltage drop limitation | I <sub>OUT</sub> =0.5A<br>T <sub>j</sub> = -40°C...+150°C |                     | 50                  |                     | mV     |

Note: 2. To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles

**Table 7. V<sub>CC</sub> - Output Diode**

| Symbol         | Parameter          | Test Conditions                                | Min | Typ | Max | Unit |
|----------------|--------------------|--|-----|-----|-----|------|
| V <sub>F</sub> | Forward on Voltage | -I <sub>OUT</sub> =2.3A; T <sub>j</sub> =150°C |     |     | 0.6 | V    |

## ELECTRICAL CHARACTERISTICS (continued)

Table 8. Current Sense CURRENT SENSE ( $9V \leq V_{CC} \leq 16V$ ) (See fig. 6)

| Symbol                          | Parameter  | Test Conditions  | Min          | Typ          | Max          | Unit   |
|---------------------------------|--|--|--------------|--------------|--------------|--------|
| K <sub>1</sub>                  | I <sub>OUT</sub> /I <sub>SENSE</sub>                       | I <sub>OUT1</sub> or I <sub>OUT2</sub> =0.5A; V <sub>SENSE</sub> =0.5V; other channels open; T <sub>j</sub> = -40°C...150°C                          | 3300         | 4400         | 6000         |        |
| dK <sub>1</sub> /K <sub>1</sub> | Current Sense Ratio Drift                                  | I <sub>OUT1</sub> or I <sub>OUT2</sub> =0.5A; V <sub>SENSE</sub> =0.5V; other channels open; T <sub>j</sub> = -40°C...150°C                          | -10          |              | +10          | %      |
| K <sub>2</sub>                  | I <sub>OUT</sub> /I <sub>SENSE</sub>                       | I <sub>OUT1</sub> or I <sub>OUT2</sub> =5A; V <sub>SENSE</sub> =4V; other channels open; T <sub>j</sub> =-40°C<br>T <sub>j</sub> =25°C...150°C       | 4200<br>4400 | 4900<br>4900 | 6000<br>5750 |        |
| dK <sub>2</sub> /K <sub>2</sub> | Current Sense Ratio Drift                                  | I <sub>OUT1</sub> or I <sub>OUT2</sub> =5A; V <sub>SENSE</sub> =4V; other channels open; T <sub>j</sub> =-40°C...150°C                               | -6           |              | +6           | %      |
| K <sub>3</sub>                  | I <sub>OUT</sub> /I <sub>SENSE</sub>                       | I <sub>OUT1</sub> or I <sub>OUT2</sub> =15A; V <sub>SENSE</sub> =4V; other channels open; T <sub>j</sub> =-40°C<br>T <sub>j</sub> =25°C...150°C      | 4200<br>4400 | 4900<br>4900 | 5500<br>5250 |        |
| dK <sub>3</sub> /K <sub>3</sub> | Current Sense Ratio Drift                                  | I <sub>OUT1</sub> or I <sub>OUT2</sub> =15A; V <sub>SENSE</sub> =4V; other channels open; T <sub>j</sub> =-40°C...150°C                              | -6           |              | +6           | %      |
| V <sub>SENSE1,2</sub>           | Max analog sense output voltage                            | V <sub>CC</sub> =5.5V; I <sub>OUT1,2</sub> =2.5A; R <sub>SENSE</sub> =10kΩ<br>V <sub>CC</sub> >8V, I <sub>OUT1,2</sub> =5A; R <sub>SENSE</sub> =10kΩ | 2<br>4       |              |              | V<br>V |
| V <sub>SENSEH</sub>             | Analog sense output voltage in overtemperature condition   | V <sub>CC</sub> =13V; R <sub>SENSE</sub> =3.9kΩ  |              | 5.5          |              | V      |
| R <sub>VSENSEH</sub>            | Analog Sense Output Impedance in Overtemperature Condition | V <sub>CC</sub> =13V; T <sub>j</sub> >T <sub>TSD</sub> ; All channels Open   |              | 400          |              | Ω      |
| t <sub>DSENSE</sub>             | Current sense delay response                               | to 90% I <sub>SENSE</sub> (see note 3)   |              |              | 500          | μs     |

Note: 3. Current sense signal delay after positive input slope.

Table 9. Switching (V<sub>CC</sub>=13V)

| Symbol                                 | Parameter              | Test Conditions                     | Min | Typ                  | Max | Unit |
|--|------------------------|-------------------------------------|-----|----------------------|-----|------|
| t <sub>d(on)</sub>                     | Turn-on delay time     | R <sub>L</sub> =2.6Ω (see figure 6) |     | 30                   |     | μs   |
| t <sub>d(off)</sub>                    | Turn-off delay time    | R <sub>L</sub> =2.6Ω (see figure 6) |     | 30                   |     | μs   |
| (dV <sub>OUT</sub> /dt) <sub>on</sub>  | Turn-on voltage slope  | R <sub>L</sub> =2.6Ω (see figure 6) |     | See relative diagram |     | V/μs |
| (dV <sub>OUT</sub> /dt) <sub>off</sub> | Turn-off voltage slope | R <sub>L</sub> =2.6Ω (see figure 6) |     | See relative diagram |     | V/μs |

Table 10. Logic Input (Channel 1, 2)

| Symbol               | Parameter                | Test Conditions                               | Min  | Typ         | Max  | Unit   |
|----------------------|--------------------------|---|------|-------------|------|--------|
| V <sub>IL</sub>      | Input low level voltage  |   |      |             | 1.25 | V      |
| I <sub>IL</sub>      | Low level input current  | V <sub>IN</sub> =1.25V                        | 1    |             |      | μA     |
| V <sub>IH</sub>      | Input high level voltage |   | 3.25 |             |      | V      |
| I <sub>IH</sub>      | High level input current | V <sub>IN</sub> =3.25V                        |      |             | 10   | μA     |
| V <sub>I(hyst)</sub> | Input hysteresis voltage |   | 0.5  |             |      | V      |
| V <sub>ICL</sub>     | Input clamp voltage      | I <sub>IN</sub> =1mA<br>I <sub>IN</sub> =-1mA | 6    | 6.8<br>-0.7 | 8    | V<br>V |

Figure 5. I<sub>OUT</sub>/I<sub>SENSE</sub> versus I<sub>OUT</sub>

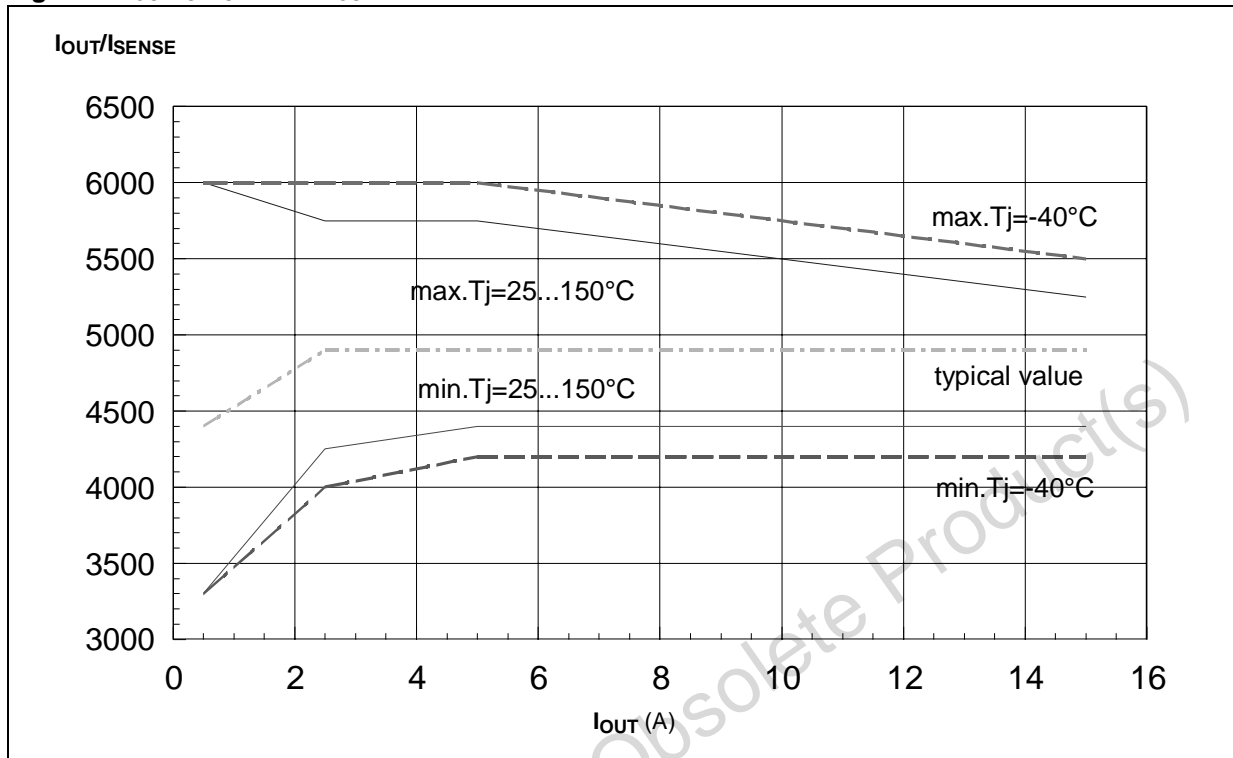


Table 11. Truth Table (per channel)

| CONDITIONS                       | INPUT | OUTPUT | SENSE   |
|----------------------------------|-------|--------|---|
| Normal operation                 | L     | L      | 0   |
|                                  | H     | H      | Nominal   |
| Overtemperature                  | L     | L      | 0   |
|                                  | H     | L      | V <sub>SENSEH</sub>                                     |
| Undervoltage                     | L     | L      | 0   |
|                                  | H     | L      | 0   |
| Overvoltage                      | L     | L      | 0   |
|                                  | H     | L      | 0   |
| Short circuit to GND             | L     | L      | 0   |
|                                  | H     | L      | (T <sub>j</sub> <T <sub>TSD</sub> ) 0                   |
|                                  | H     | L      | (T <sub>j</sub> >T <sub>TSD</sub> ) V <sub>SENSEH</sub> |
| Short circuit to V <sub>CC</sub> | L     | H      | 0   |
|                                  | H     | H      | < Nominal   |
| Negative output voltage clamp    | L     | L      | 0   |

Figure 6. Switching Characteristics (Resistive load  $R_L=2.6\Omega$ )

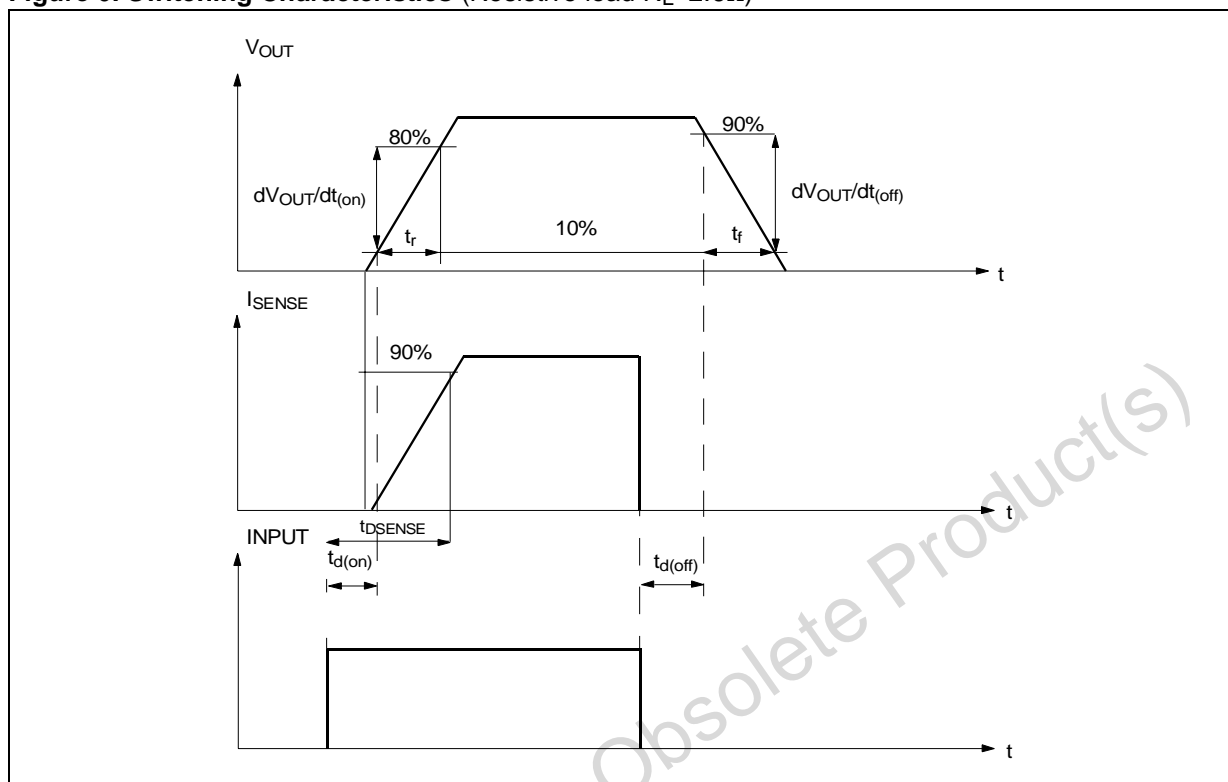


Table 12. Electrical Transient Requirements On  $V_{CC}$  Pin

| ISO T/R 7637/1<br>Test Pulse | TEST LEVELS |         |         |         | Delays and Impedance    |
|------------------------------|-------------|---------|---------|---------|-------------------------|
|                              | I           | II      | III     | IV      |                         |
| 1                            | -25 V       | -50 V   | -75 V   | -100 V  | 2 ms 10 $\Omega$        |
| 2                            | +25 V       | +50 V   | +75 V   | +100 V  | 0.2 ms 10 $\Omega$      |
| 3a                           | -25 V       | -50 V   | -100 V  | -150 V  | 0.1 $\mu$ s 50 $\Omega$ |
| 3b                           | +25 V       | +50 V   | +75 V   | +100 V  | 0.1 $\mu$ s 50 $\Omega$ |
| 4                            | -4 V        | -5 V    | -6 V    | -7 V    | 100 ms, 0.01 $\Omega$   |
| 5                            | +26.5 V     | +46.5 V | +66.5 V | +86.5 V | 400 ms, 2 $\Omega$      |

| ISO T/R 7637/1<br>Test Pulse | TEST LEVELS RESULTS |    |     |    |
|------------------------------|---------------------|----|-----|----|
|                              | I                   | II | III | IV |
| 1                            | C                   | C  | C   | C  |
| 2                            | C                   | C  | C   | C  |
| 3a                           | C                   | C  | C   | C  |
| 3b                           | C                   | C  | C   | C  |
| 4                            | C                   | C  | C   | C  |
| 5                            | C                   | E  | E   | E  |

| CLASS | CONTENTS  |
|-------|---|
| C     | All functions of the device are performed as designed after exposure to disturbance.  |
| E     | One or more functions of the device is not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device. |

Figure 7. Waveforms

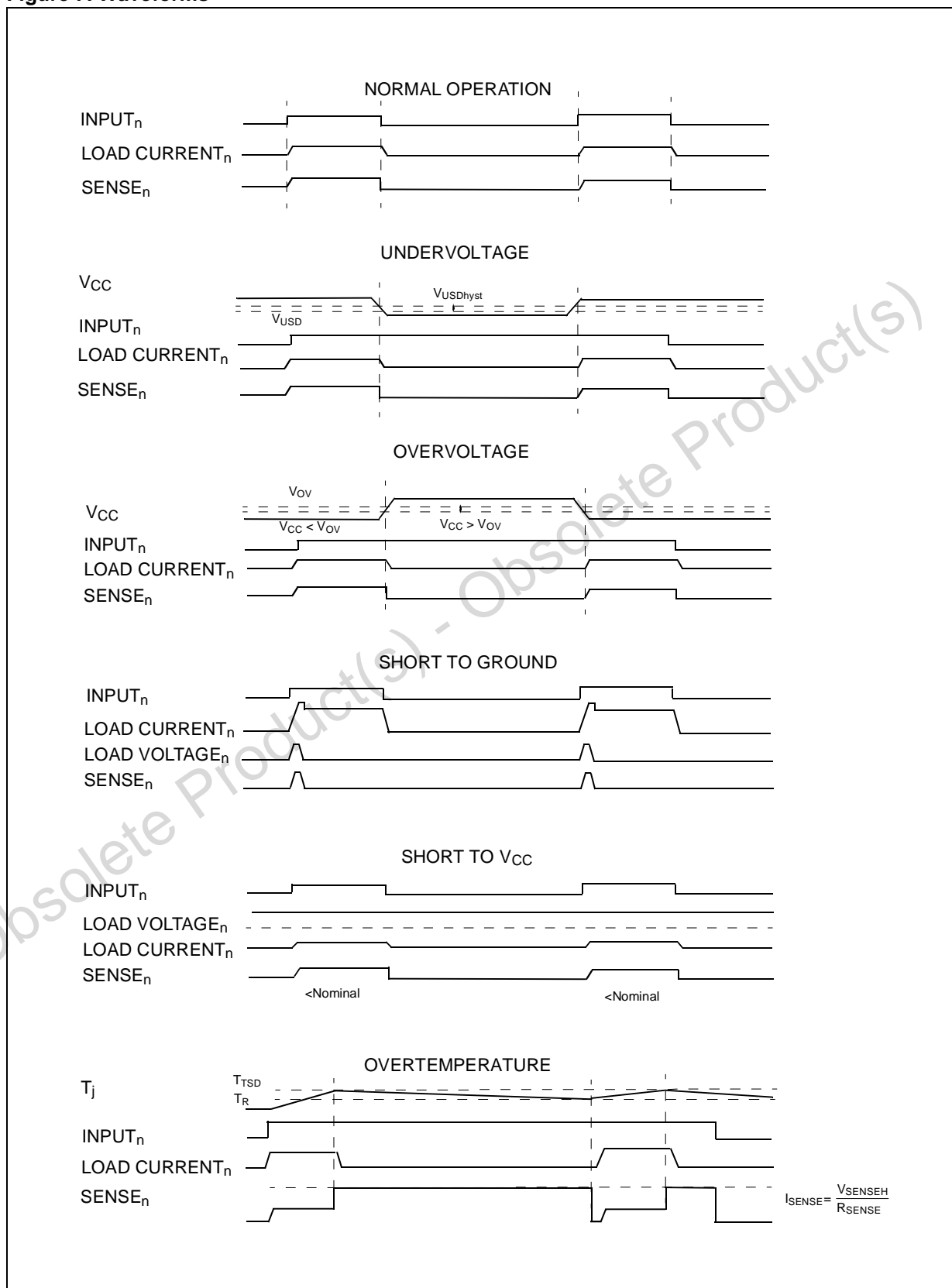
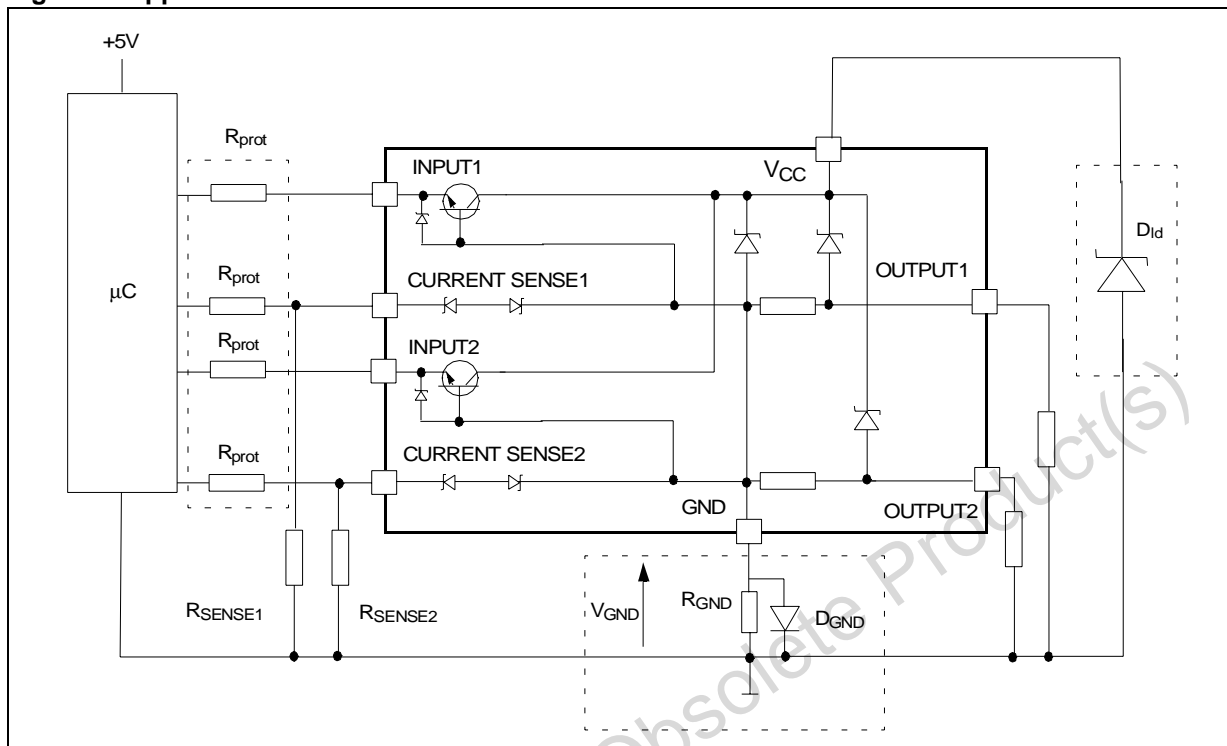


Figure 8. Application Schematic



### GND PROTECTION NETWORK AGAINST REVERSE BATTERY

**Solution 1:** Resistor in the ground line ( $R_{GND}$  only). This can be used with any type of load.

The following is an indication on how to dimension the  $R_{GND}$  resistor.

- 1)  $R_{GND} \leq 600\text{mV} / I_{S(\text{on})\text{max}}$ .
- 2)  $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where  $-I_{GND}$  is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device's datasheet.

Power Dissipation in  $R_{GND}$  (when  $V_{CC} < 0$ : during reverse battery situations) is:

$$P_D = (-V_{CC})^2 / R_{GND}$$

This resistor can be shared amongst several different HSD. Please note that the value of this resistor should be calculated with formula (1) where  $I_{S(\text{on})\text{max}}$  becomes the sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not common with the device ground then the  $R_{GND}$  will produce a shift ( $I_{S(\text{on})\text{max}} * R_{GND}$ ) in the input thresholds and the status output values. This shift will vary depending on how many devices are ON in the case of several high side drivers sharing the same  $R_{GND}$ .

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then the ST suggests to utilize Solution 2 (see below).

**Solution 2:** A diode ( $D_{GND}$ ) in the ground line.

A resistor ( $R_{GND} = 1\text{k}\Omega$ ) should be inserted in parallel to  $D_{GND}$  if the device will be driving an inductive load.

This small signal diode can be safely shared amongst several different HSDs.

Also in this case, the presence of the ground network will produce a shift ( $\approx 600\text{mV}$ ) in the input thresholds and the status output values if the microprocessor ground is not common with the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

Series resistor in INPUT and STATUS lines are also required to prevent that, during battery voltage transient, the current exceeds the Absolute Maximum Rating.

Safest configuration for unused INPUT and STATUS pin is to leave them unconnected.

### LOAD DUMP PROTECTION

$D_{ld}$  is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds  $V_{CC}$  max DC rating. The same applies if the device will be subject to transients on the  $V_{CC}$  line that are greater than the ones shown in the ISO T/R 7637/1 table.

### µC I/Os PROTECTION:

If a ground protection network is used and negative transient are present on the  $V_{CC}$  line, the control pins will be pulled negative. ST suggests to insert a resistor ( $R_{prot}$ ) in line to prevent the  $\mu\text{C}$  I/Os pins to latch-up.

The value of these resistors is a compromise between the leakage current of  $\mu\text{C}$  and the current required by the HSD I/Os (Input levels compatibility) with the latch-up limit of  $\mu\text{C}$  I/Os.

$$-V_{CC\text{peak}} / I_{\text{latchup}} \leq R_{\text{prot}} \leq (V_{OH\mu\text{C}} - V_{IH} - V_{GND}) / I_{IH\text{max}}$$

Calculation example:

For  $V_{CC\text{peak}} = -100\text{V}$  and  $I_{\text{latchup}} \geq 20\text{mA}$ ;  $V_{OH\mu\text{C}} \geq 4.5\text{V}$   
 $5\text{k}\Omega \leq R_{\text{prot}} \leq 65\text{k}\Omega$ .

Recommended  $R_{\text{prot}}$  value is  $10\text{k}\Omega$ .

Figure 9. Off State Output Current

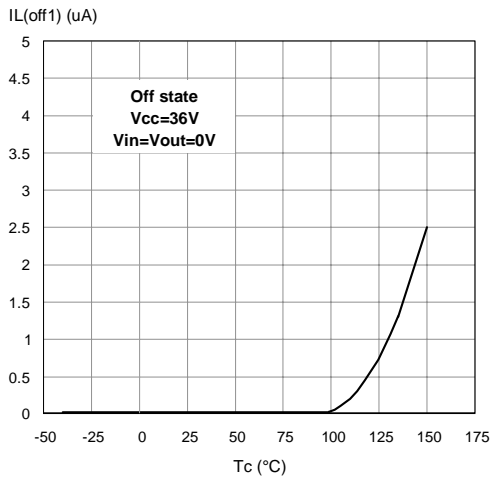


Figure 10. High Level Input Current

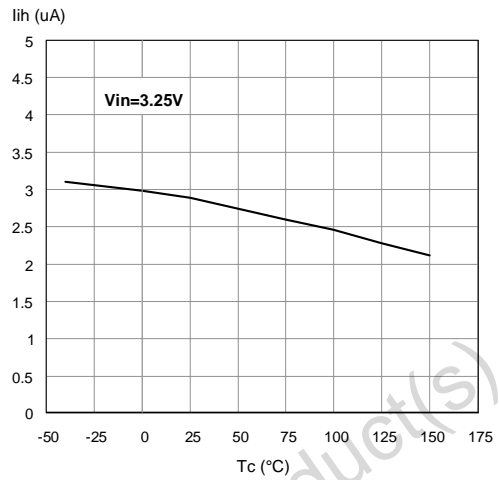


Figure 11. Input Clamp Voltage

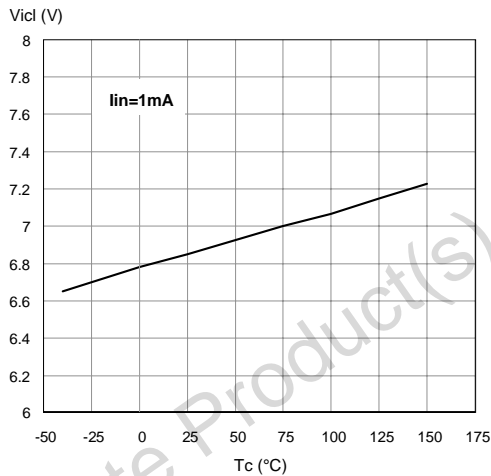


Figure 13. Input High Level

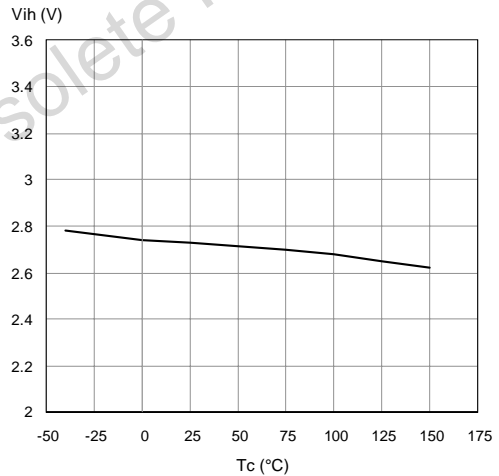


Figure 12. Input Low Level

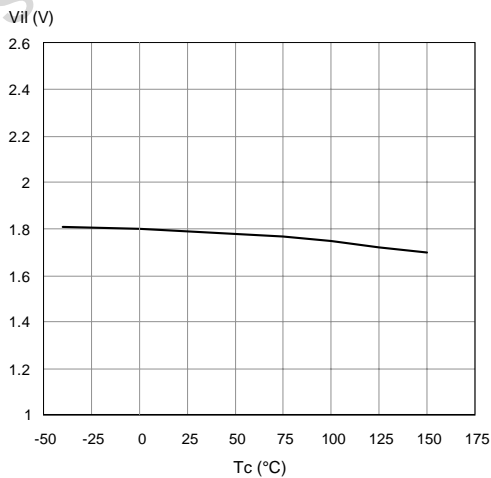


Figure 14. Input Hysteresis Voltage

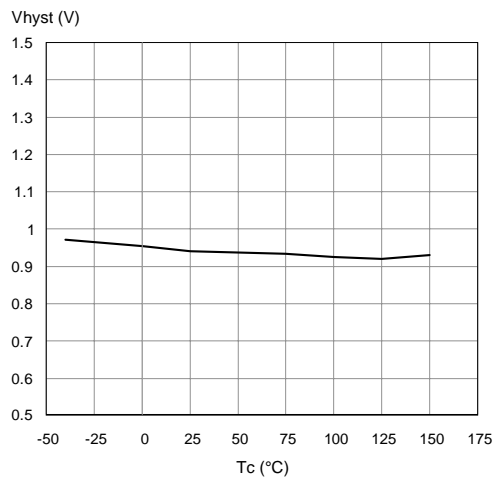


Figure 15. Overvoltage Shutdown

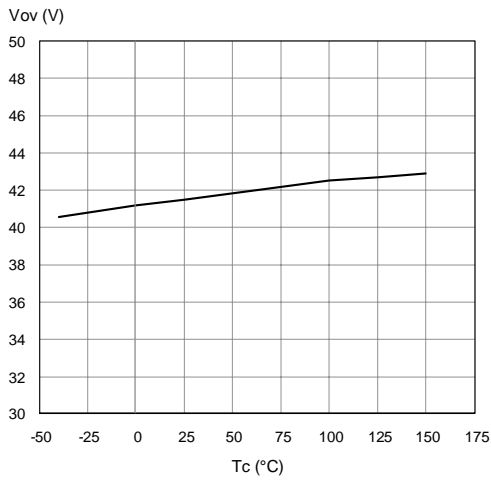


Figure 18. I<sub>LIM</sub> Vs T<sub>case</sub>

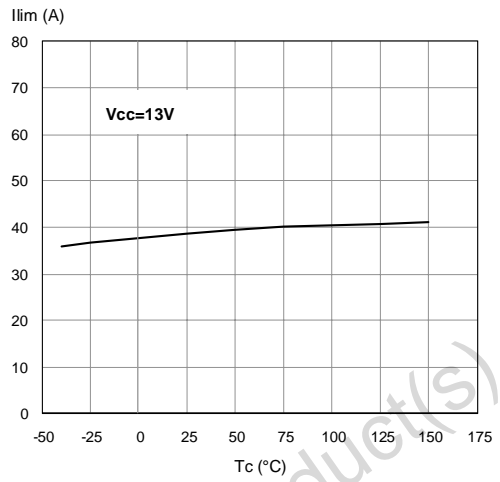


Figure 16. Turn-on Voltage Slope

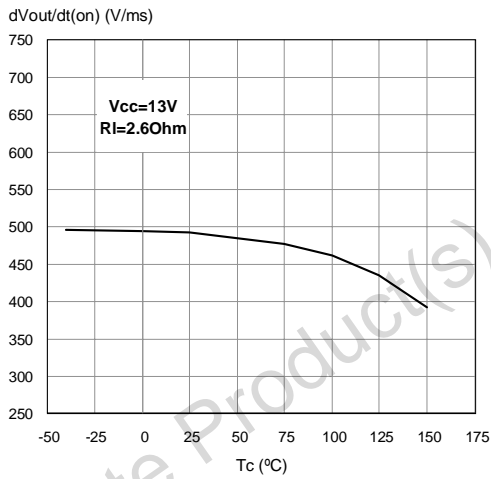


Figure 19. Turn-off Voltage Slope

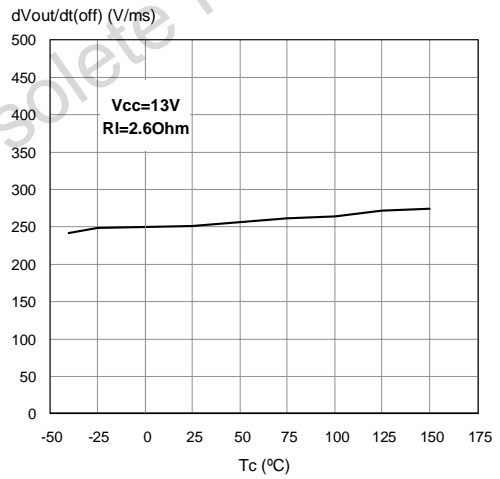


Figure 17. On State Resistance Vs T<sub>case</sub>

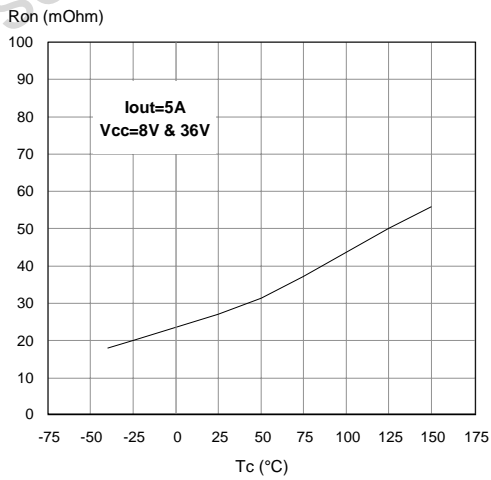


Figure 20. On State Resistance Vs V<sub>CC</sub>

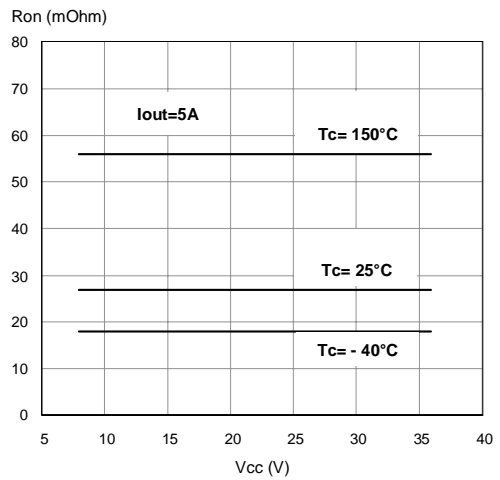
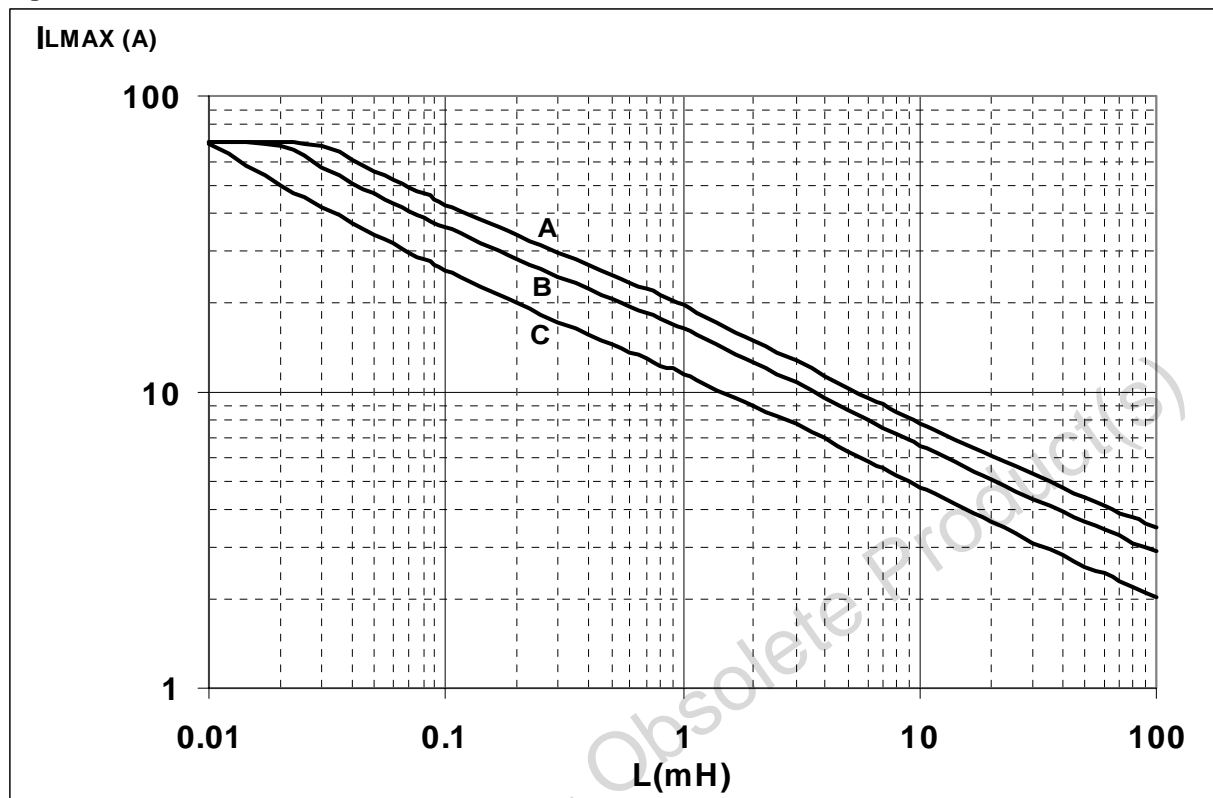


Figure 21. SO-16L Maximum turn off current versus load inductance



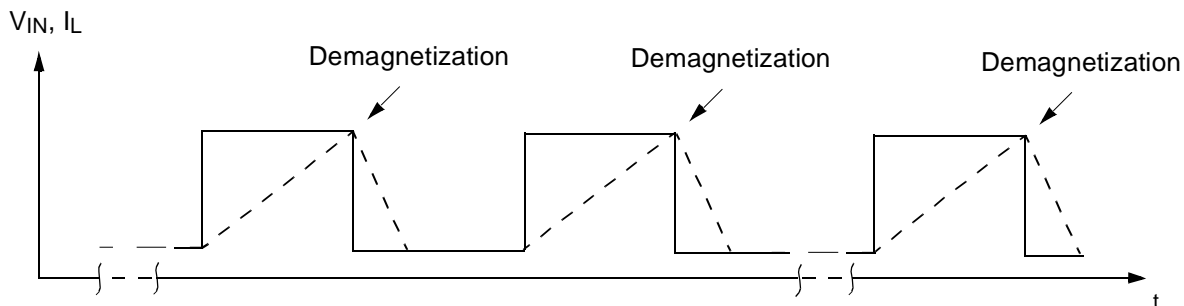
- A = Single Pulse at  $T_{jstart}=150^{\circ}C$
- B= Repetitive pulse at  $T_{jstart}=100^{\circ}C$
- C= Repetitive Pulse at  $T_{jstart}=125^{\circ}C$

Values are generated with  $R_L=0\Omega$

In case of repetitive pulses,  $T_{jstart}$  (at beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves B and C.

Conditions:

$V_{CC}=13.5V$



SO-16L Thermal Data

Figure 22. SO-16L PC Board

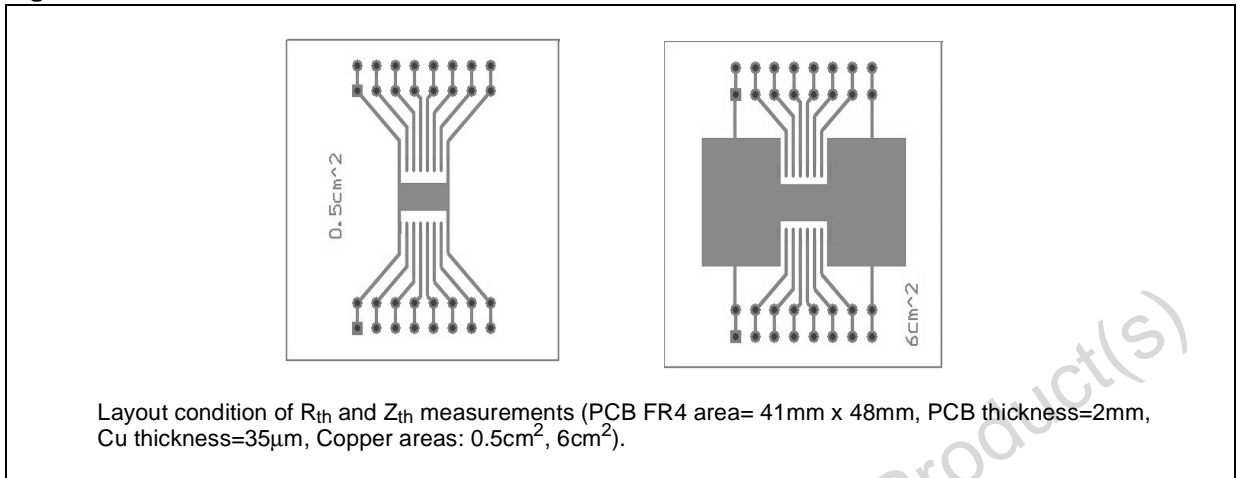


Figure 23.  $R_{thj-amb}$  Vs PCB copper area in open box free air condition

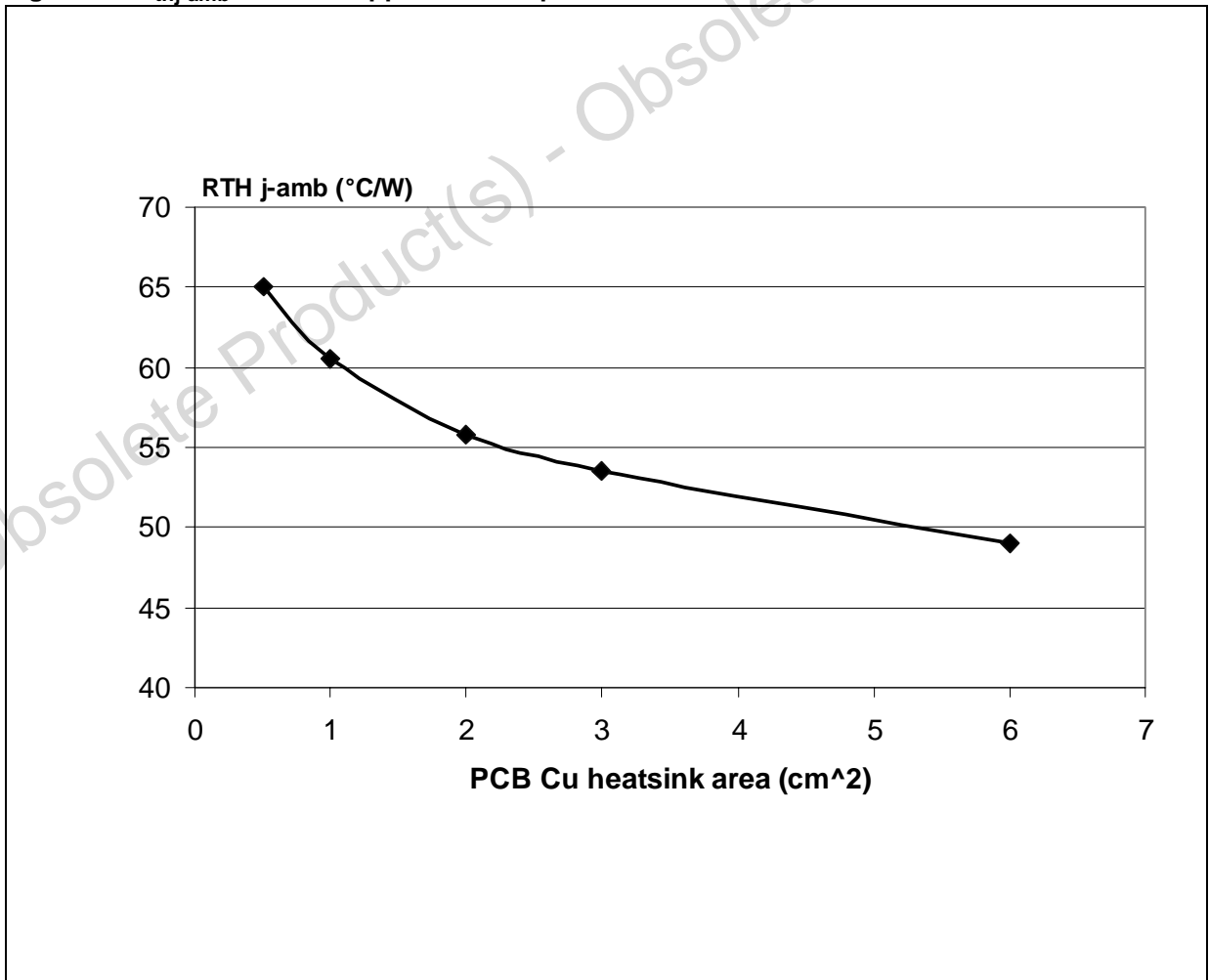


Figure 24. SO-16L Thermal Impedance Junction Ambient Single Pulse

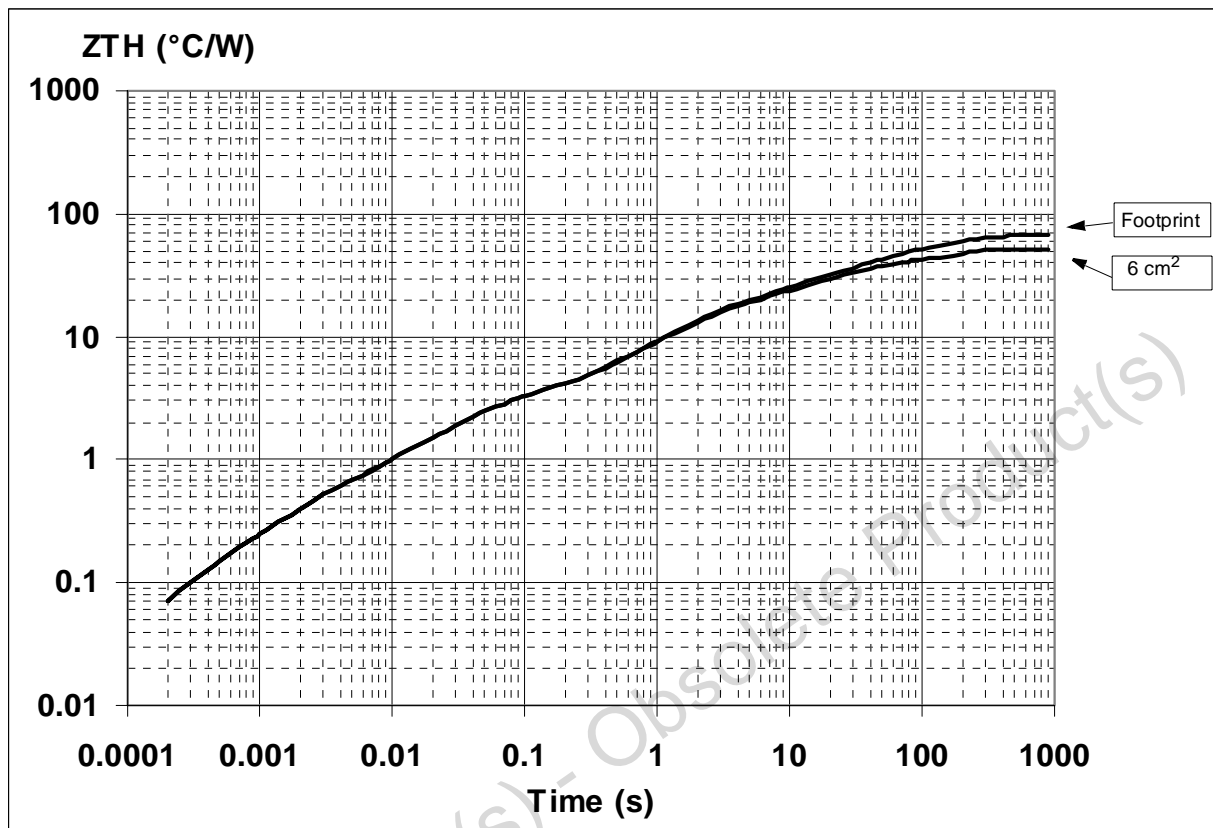
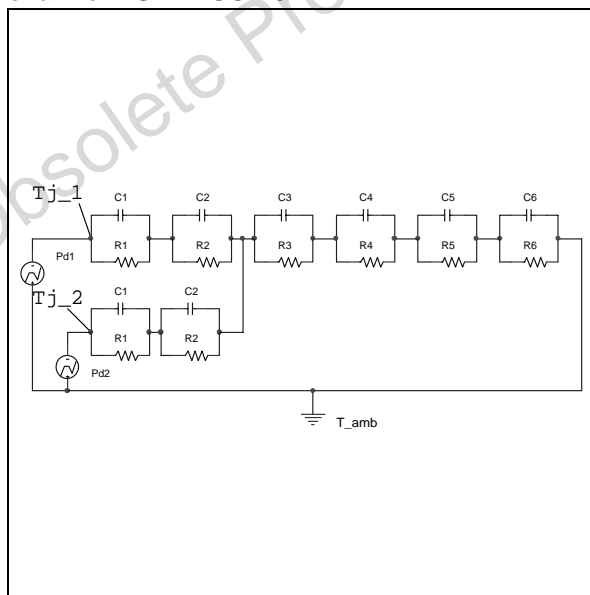


Figure 25. Thermal fitting model of a double channel HSD in SO-16L



Pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where  $\delta = t_p/T$

Table 13. Thermal Parameter

| Area/island (cm <sup>2</sup> ) | Footprint | 6  |
|--------------------------------|-----------|----|
| R1 (°C/W)                      | 0.05      |    |
| R2 (°C/W)                      | 0.3       |    |
| R3 (°C/W)                      | 2.2       |    |
| R4 (°C/W)                      | 12        |    |
| R5 (°C/W)                      | 15        |    |
| R6 (°C/W)                      | 37        | 22 |
| C1 (W.s/°C)                    | 0.001     |    |
| C2 (W.s/°C)                    | 5.00E-03  |    |
| C3 (W.s/°C)                    | 0.02      |    |
| C4 (W.s/°C)                    | 0.3       |    |
| C5 (W.s/°C)                    | 1         |    |
| C6 (W.s/°C)                    | 3         | 5  |

## PACKAGE MECHANICAL

Table 14. SO-16L Mechanical Data

| Symbol | millimeters |            |       |
|--------|-------------|------------|-------|
|        | Min         | Typ        | Max   |
| A      |             |            | 2.65  |
| a1     | 0.1         |            | 0.2   |
| a2     |             |            | 2.45  |
| b      | 0.35        |            | 0.49  |
| b1     | 0.23        |            | 0.32  |
| C      |             | 0.5        |       |
| c1     |             | 45° (typ.) |       |
| D      | 10.1        |            | 10.5  |
| E      | 10.0        |            | 10.65 |
| e      |             | 1.27       |       |
| e3     |             | 8.89       |       |
| F      | 7.4         |            | 7.6   |
| L      | 0.5         |            | 1.27  |
| M      |             |            | 0.75  |
| S      |             | 8° (max.)  |       |

Figure 26. SO-16L Package Dimensions

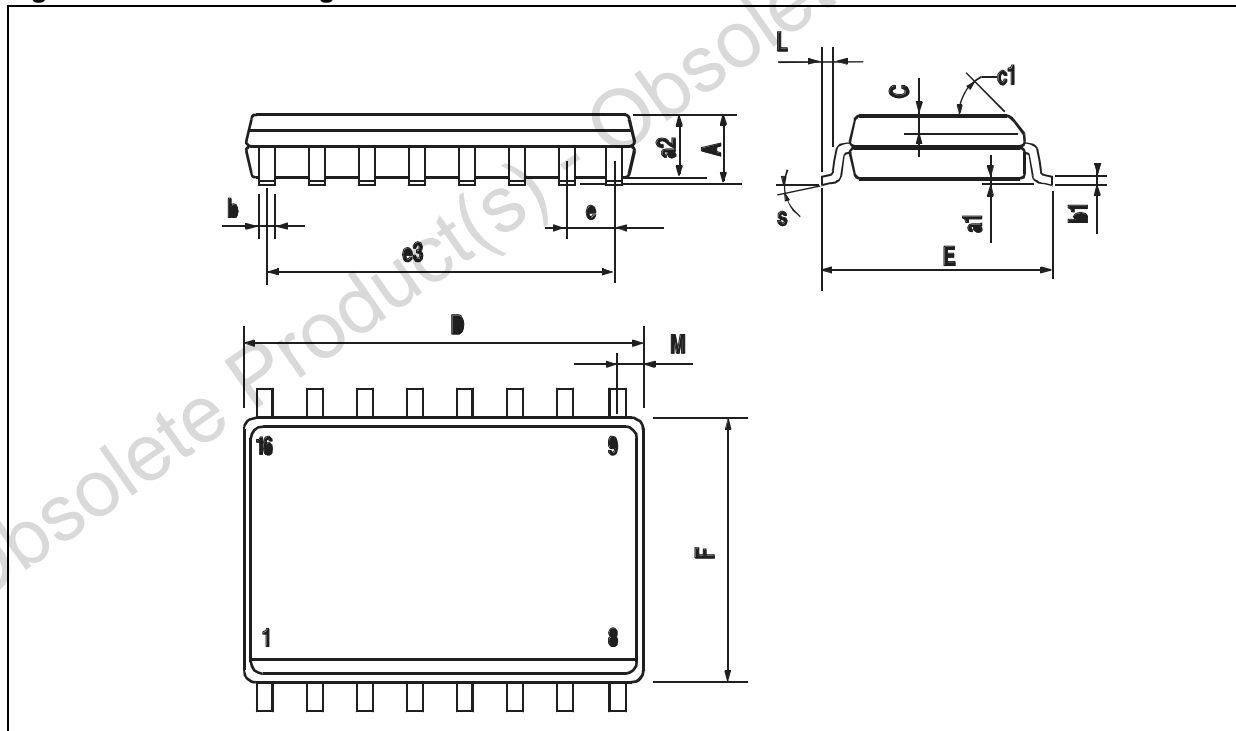


Figure 27. SO-16L Tube Shipment (No Suffix)

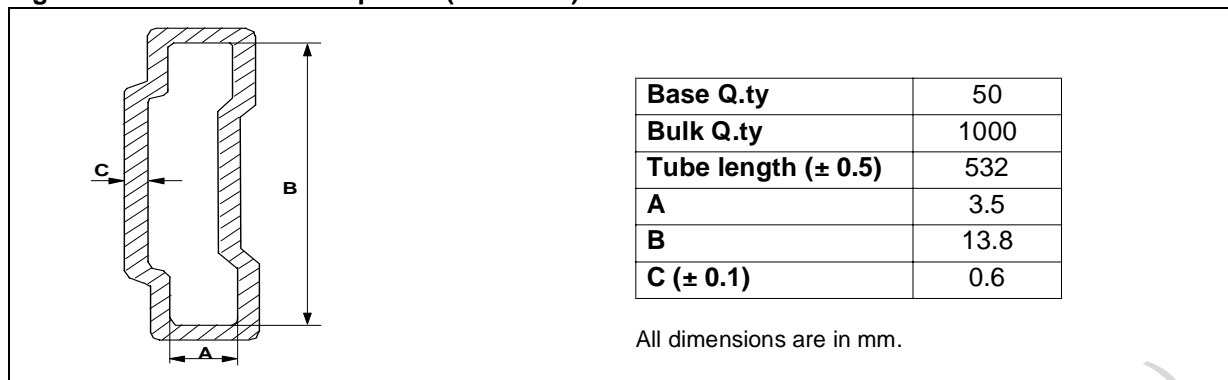
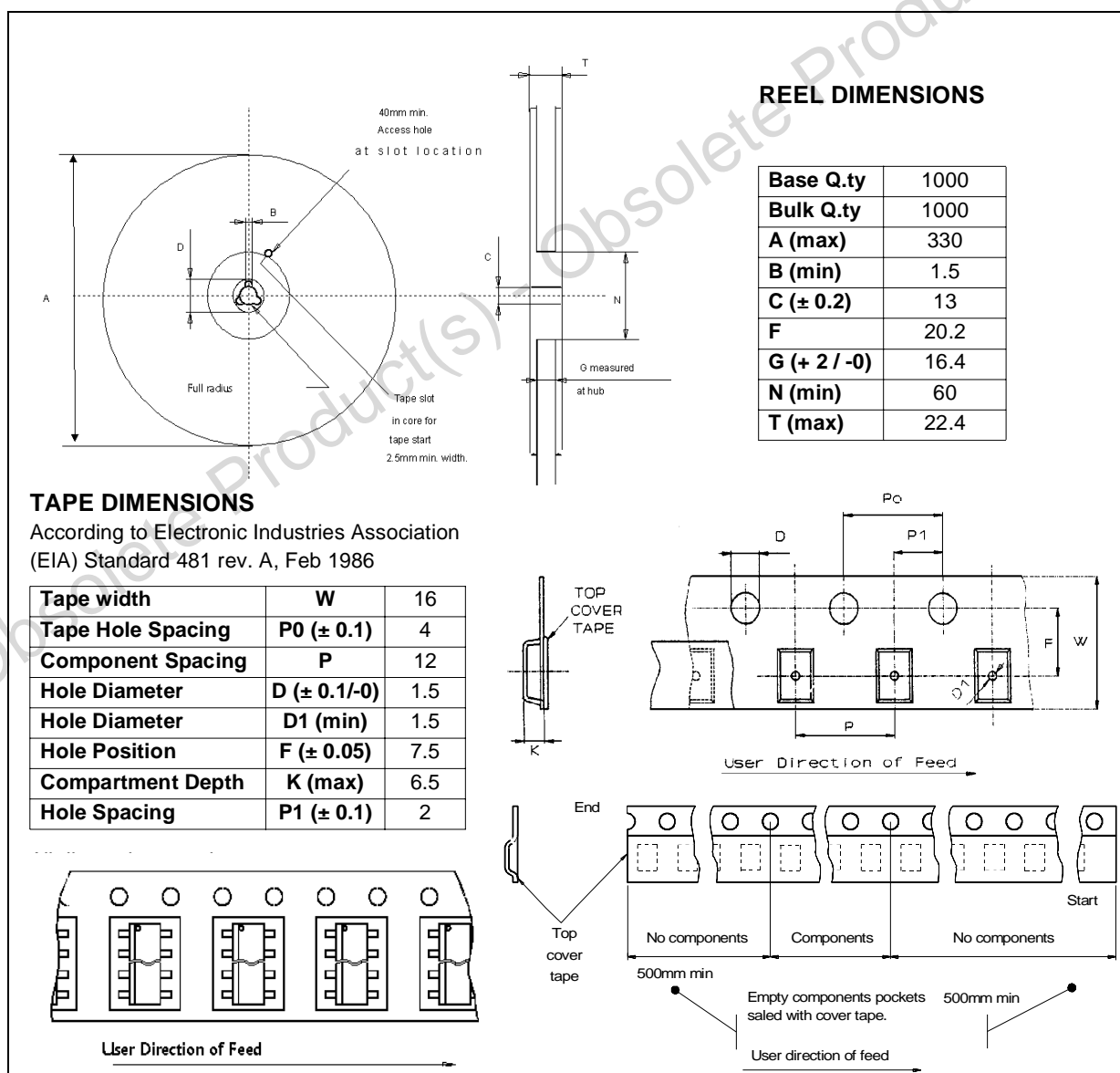


Figure 28. Tape And Reel Shipment (Suffix "TR")



**REVISION HISTORY**

| Date      | Revision | Description of Changes |
|-----------|----------|------------------------|
| Oct. 2004 | 1        | - First Issue.         |

Obsolete Product(s) - Obsolete Product(s)

Obsolete Product(s) - Obsolete Product(s)

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